

# EPC2106 – Enhancement-Mode GaN Power Transistor Half-Bridge

$V_{DS}$ , 100 V

$R_{DS(on)}$ , 70 mΩ

$I_D$ , 1.7 A



Revised January 27, 2021

Gallium Nitride’s exceptionally high electron mobility and low temperature coefficient allows very low  $R_{DS(on)}$ , while its lateral device structure and majority carrier diode provide exceptionally low  $Q_G$  and zero  $Q_{RR}$ . The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

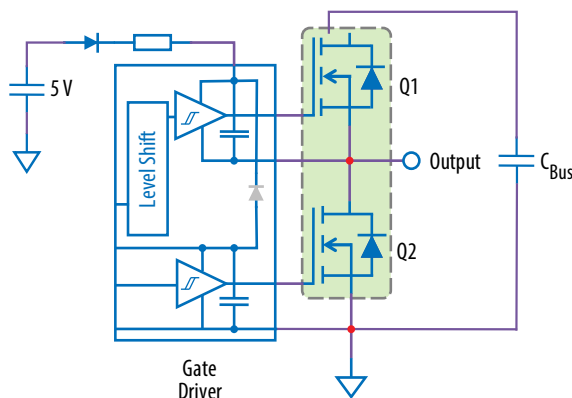


Maximum Ratings				
DEVICE	PARAMETER		VALUE	UNIT
Q1 & Q2	$V_{DS}$	Drain-to-Source Voltage (Continuous)	100	V
		Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	120	
	$I_D$	Continuous ( $T_A = 25^\circ\text{C}$ , $R_{\theta JA} = 320^\circ\text{C/W}$ )	1.7	A
		Pulsed ( $25^\circ\text{C}$ , $T_{PULSE} = 300 \mu\text{s}$ )	18	
	$V_{GS}$	Gate-to-Source Voltage	6	V
		Gate-to-Source Voltage	-4	
	$T_J$	Operating Temperature	-40 to 150	°C
	$T_{STG}$	Storage Temperature	-40 to 150	

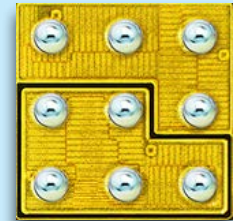
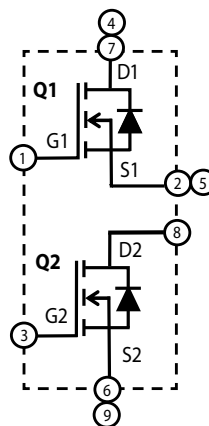
Thermal Characteristics			
PARAMETER		TYP	UNIT
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	3	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Board	30	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	81	

Note 1:  $R_{\theta JA}$  is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See [https://epc-co.com/epc/documents/product-training/Appnote\\_Thermal\\_Performance\\_of\\_eGaN\\_FETs.pdf](https://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf) for details

## Typical Application Circuit



## EPC2106 – Detailed Schematic



Die Size: 1.35 x 1.35 mm

EPC2106 eGaN® ICs are supplied only in passivated die form with solder bumps.

### Applications

- High frequency DC-DC conversion
- Class-D audio

### Benefits

- Ultra high efficiency
- Ultra low  $R_{DS(on)}$
- Ultra low  $Q_G$
- Ultra small footprint

Scan QR code or click link below for more information including reliability reports, device models, demo boards!



<https://l.ead.me/EPC2106>

Static Characteristics ( $T_J = 25^\circ\text{C}$  unless otherwise stated)

DEVICE	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Q1 & Q2	$BV_{DSS}$	Drain-to-Source Voltage	$V_{GS} = 0\text{ V}, I_D = 0.3\text{ mA}$	100			V
	$I_{DSS}$	Drain-Source Leakage	$V_{DS} = 80\text{ V}, V_{GS} = 0\text{ V}$		0.001	0.25	mA
	$I_{GSS}$	Gate-to-Source Forward Leakage	$V_{GS} = 5\text{ V}$		0.01	1	mA
		Gate-to-Source Reverse Leakage	$V_{GS} = -4\text{ V}$		0.001	0.25	mA
	$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 0.6\text{ mA}$	0.8	1.4	2.5	V
	$R_{DS(on)}$	Drain-Source On Resistance	$V_{GS} = 5\text{ V}, I_D = 2\text{ A}$		55	70	m $\Omega$
	$V_{SD}$	Source-Drain Forward Voltage	$I_S = 0.35\text{ A}, V_{GS} = 0\text{ V}$		2.1		V

Dynamic Characteristics ( $T_J = 25^\circ\text{C}$  unless otherwise stated)

DEVICE	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Q1	$C_{ISS}$	Input Capacitance	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V}$		79	95	pF
	$C_{RSS}$	Reverse Transfer Capacitance			0.5		
	$C_{OSS}$	Output Capacitance			52	78	
	$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 2)	$V_{DS} = 0\text{ to }50\text{ V}, V_{GS} = 0\text{ V}$		63		pF
	$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 3)			79		
	$R_G$	Gate Resistance			1.3		$\Omega$
	$Q_G$	Total Gate Charge	$V_{DS} = 50\text{ V}, V_{GS} = 5\text{ V}, I_D = 2\text{ A}$		730	900	pC
	$Q_{GS}$	Gate to Source Charge			240		
	$Q_{GD}$	Gate to Drain Charge			140		
	$Q_{G(TH)}$	Gate Charge at Threshold			165		pC
	$Q_{OSS}$	Output Charge	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V}$		3960	5940	pC
	$Q_{RR}$	Source-Drain Recovery Charge			0		pC
Q2	$C_{ISS}$	Input Capacitance	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V}$		79	95	pF
	$C_{RSS}$	Reverse Transfer Capacitance			0.5		
	$C_{OSS}$	Output Capacitance			61	92	
	$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 2)	$V_{DS} = 0\text{ to }50\text{ V}, V_{GS} = 0\text{ V}$		74		pF
	$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 3)			94		
	$R_G$	Gate Resistance			1.8		$\Omega$
	$Q_G$	Total Gate Charge	$V_{DS} = 50\text{ V}, V_{GS} = 5\text{ V}, I_D = 2\text{ A}$		730	900	pC
	$Q_{GS}$	Gate to Source Charge			240		
	$Q_{GD}$	Gate to Drain Charge			140		
	$Q_{G(TH)}$	Gate Charge at Threshold			165		pC
	$Q_{OSS}$	Output Charge	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V}$		4680	7020	pC
	$Q_{RR}$	Source-Drain Recovery Charge			0		pC

Note 2:  $C_{OSS(ER)}$  is a fixed capacitance that gives the same stored energy as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to 50%  $BV_{DSS}$ .

Note 3:  $C_{OSS(TR)}$  is a fixed capacitance that gives the same charging time as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to 50%  $BV_{DSS}$ .

Figure 1 (Q1 & Q2): Typical Output Characteristics at 25°C

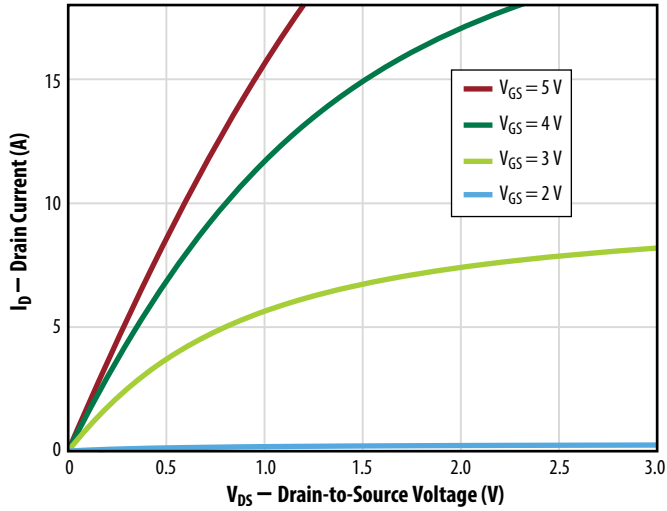


Figure 2 (Q1 & Q2): Typical Transfer Characteristics

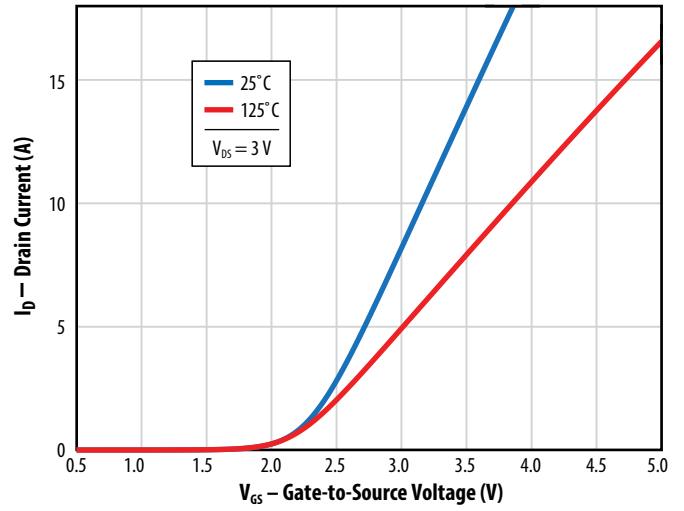


Figure 3 (Q1 & Q2): Typical  $R_{DS(on)}$  vs.  $V_{GS}$  for Various Drain Currents

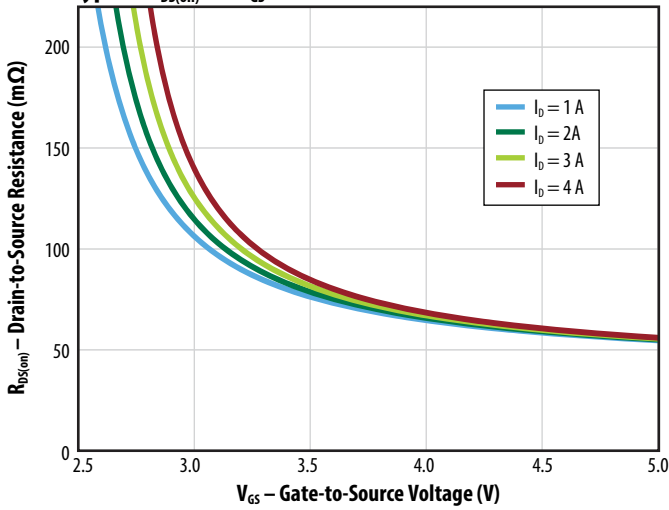


Figure 4 (Q1 & Q2): Typical  $R_{DS(on)}$  vs.  $V_{GS}$  for Various Temperatures

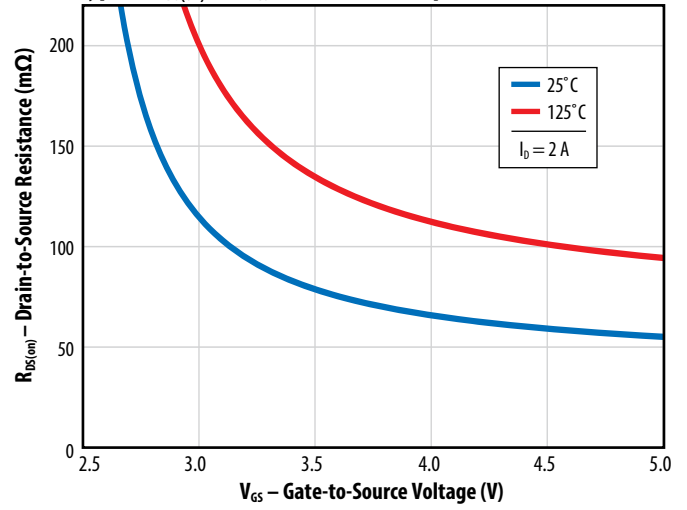


Figure 5a (Q1): Typical Capacitance (Linear Scale)

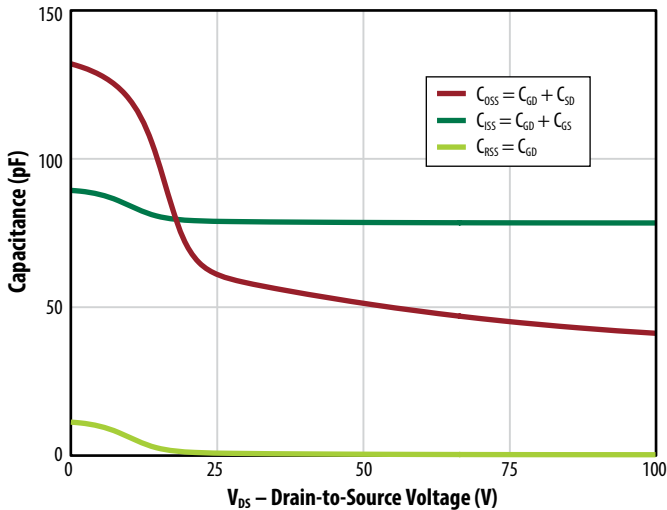


Figure 5b (Q1): Typical Capacitance (Log Scale)

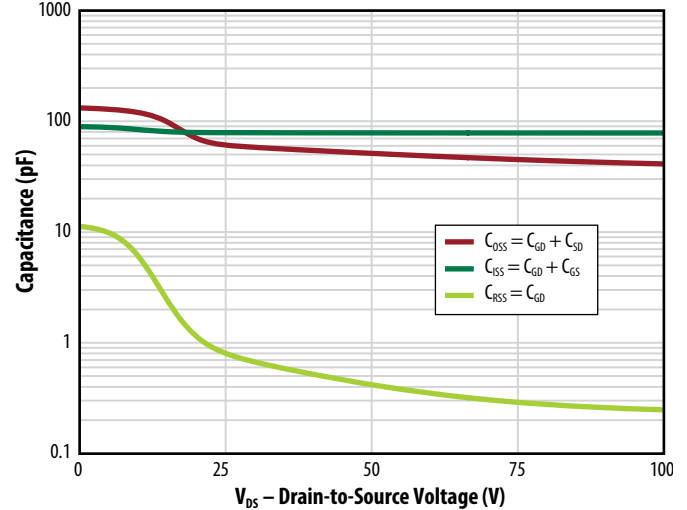


Figure 5c (Q2): Typical Capacitance (Linear Scale)

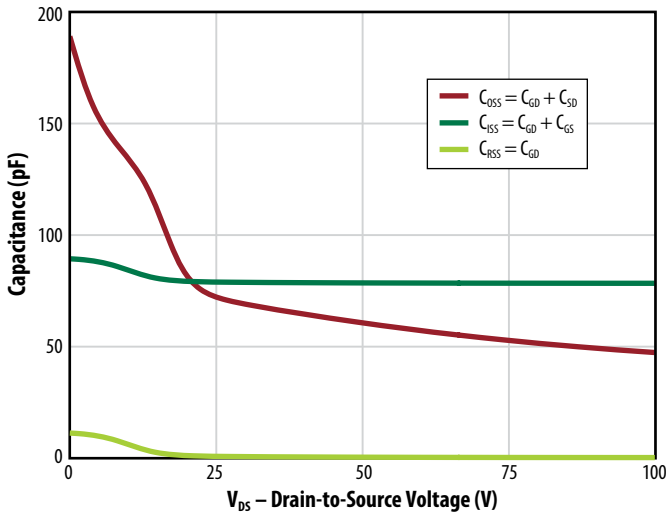


Figure 5d (Q2): Typical Capacitance (Log Scale)

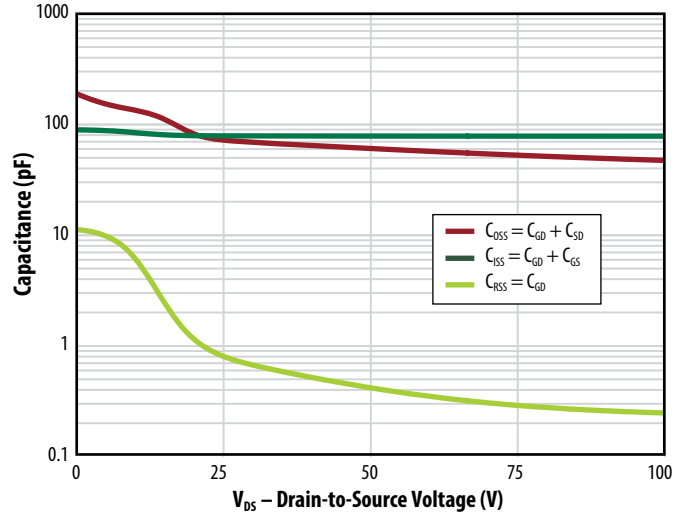


Figure 6a (Q1): Typical Output Charge and  $C_{oss}$  Stored Energy

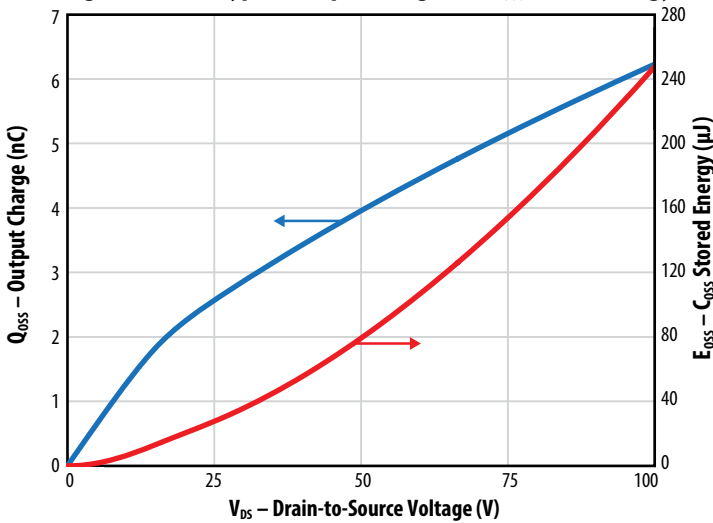


Figure 6b (Q2): Typical Output Charge and  $C_{oss}$  Stored Energy

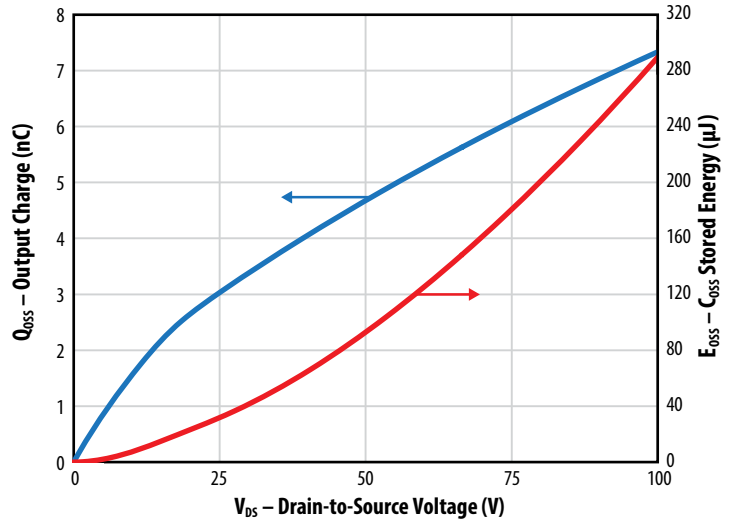


Figure 7 (Q1 & Q2): Typical Gate Charge

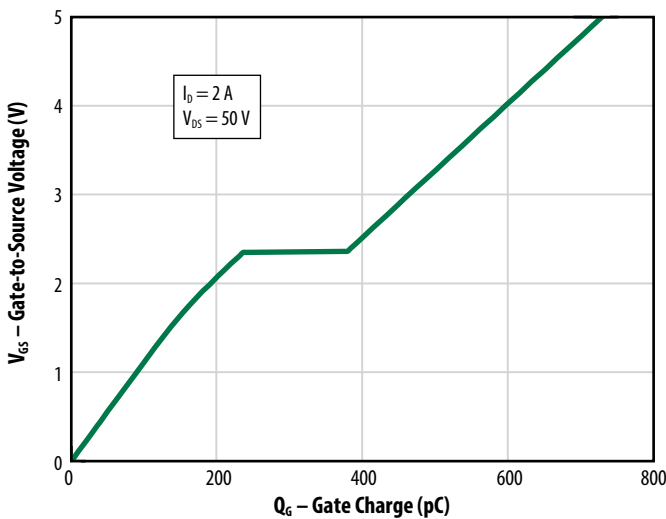
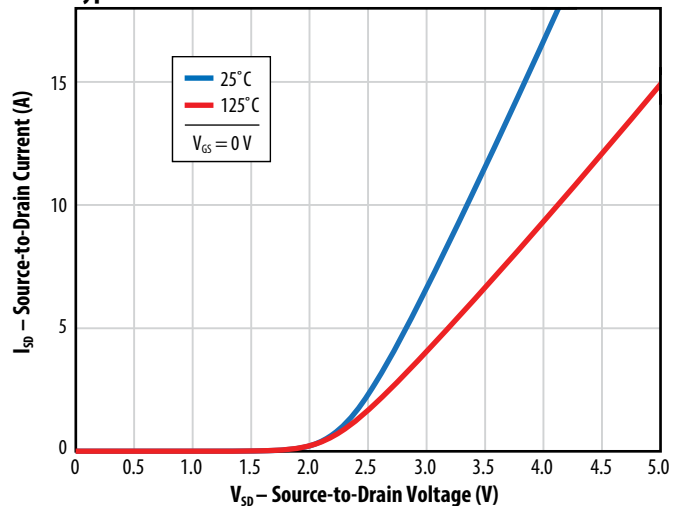
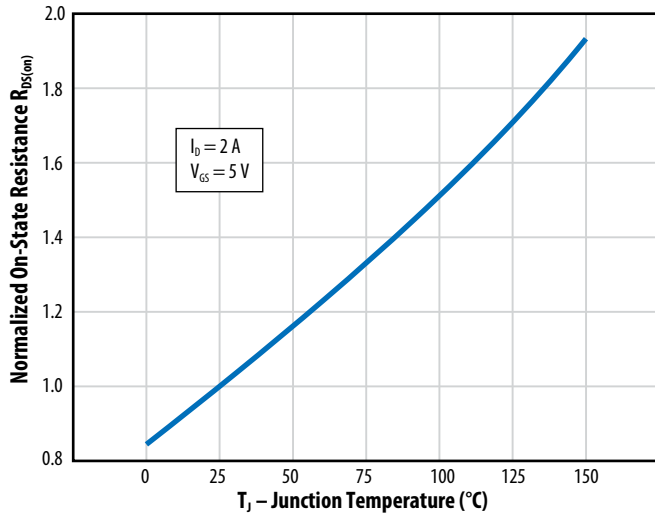


Figure 8 (Q1 & Q2): Typical Reverse Drain-Source Characteristics

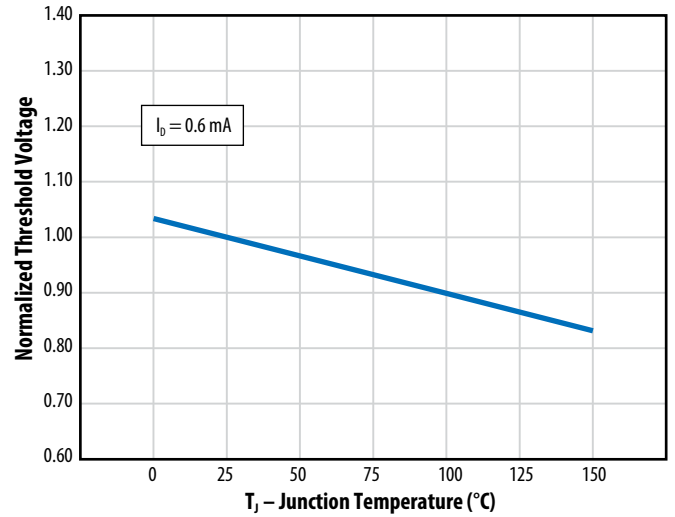


Note: Negative gate drive voltage increases the reverse drain-source voltage. EPC recommends 0V for OFF.

**Figure 9 (Q1 & Q2):  
Typical Normalized On-State Resistance vs. Temperature**



**Figure 10 (Q1 & Q2):  
Typical Normalized Threshold Voltage vs. Temperature**



**Figure 12 (Q1 & Q2): Typical Transient Thermal Response Curves**

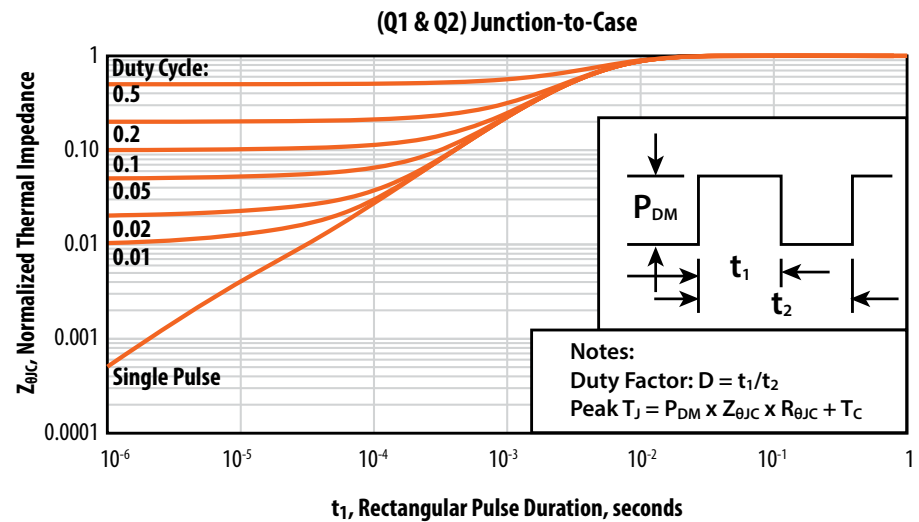
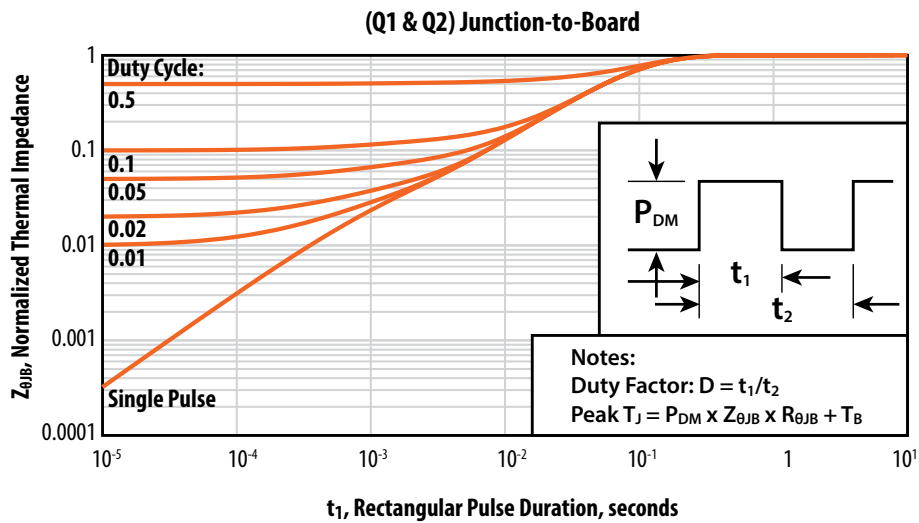
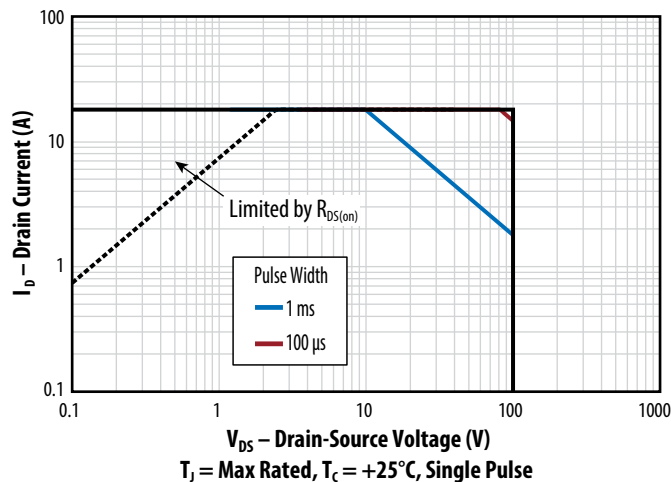
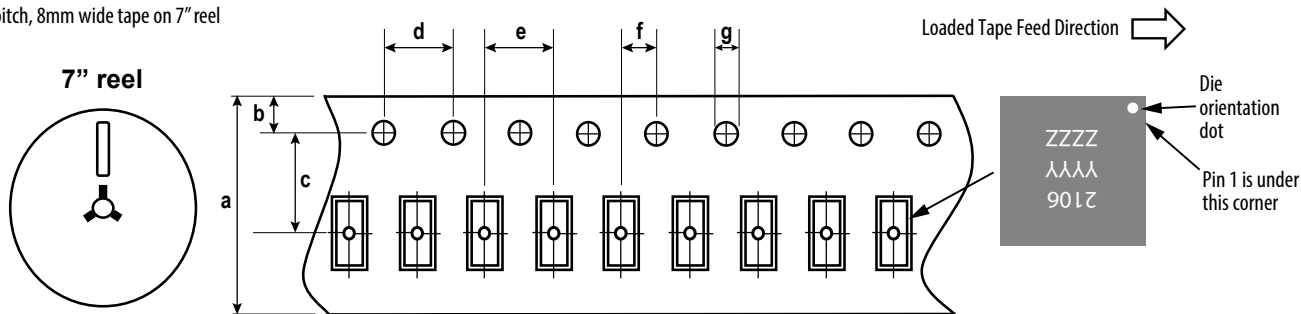


Figure 12 (Q1 & Q2): Safe Operating Area



TAPE AND REEL CONFIGURATION

4mm pitch, 8mm wide tape on 7" reel

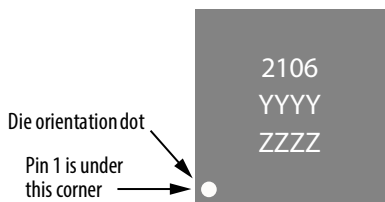


Die is placed into pocket solder bump side down (face side down)

Dimension (mm)	EPC2106 (note 1)		
	target	min	max
a	8.00	7.90	8.30
b	1.75	1.65	1.85
c (see note)	3.50	3.45	3.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (see note)	2.00	1.95	2.05
g	1.5	1.5	1.6

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.  
 Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

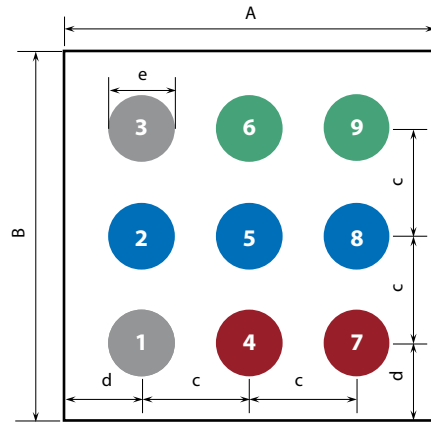
DIE MARKINGS



Part Number	Laser Markings		
	Part # Marking Line 1	Lot_Date Code Marking Line 2	Lot_Date Code Marking Line 3
EPC2106	2106	YYYY	ZZZZ

**DIE OUTLINE**

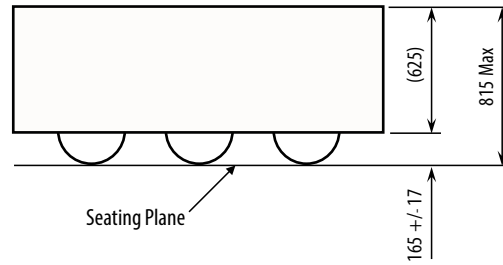
Solder Bump View



Pad 1 is Gate1 (high side)  
 Pad 3 is Gate2 (low side)  
 Pads 4, 7 are  $V_m$   
 Pads 2, 5, 8 are Switch Node  
 Pads 6, 9 are Ground

DIM	Micrometers		
	MIN	Nominal	MAX
A	1320	1350	1380
B	1320	1350	1380
c	450	450	450
d	210	225	240
e	187	208	229

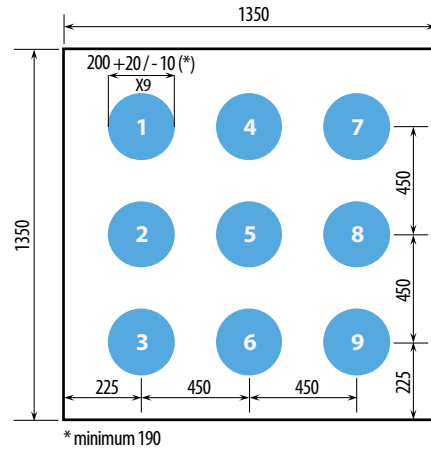
Side View



**RECOMMENDED**

**LAND PATTERN**

(measurements in  $\mu m$ )

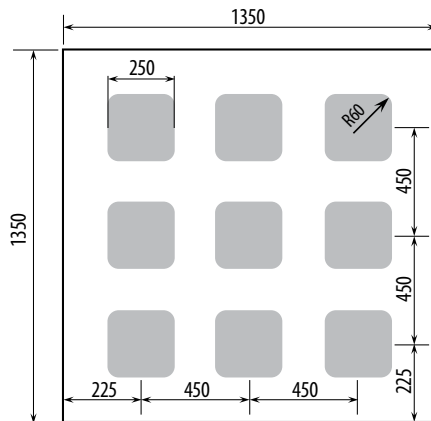


The land pattern is solder mask defined.

**RECOMMENDED**

**STENCIL DRAWING**

(measurements in  $\mu m$ )



Recommended stencil should be 4 mil (100  $\mu m$ ) thick, must be laser cut, openings per drawing.

Intended for use with SAC305 Type 4 solder, reference 88.5% metals content.

Additional assembly resources available at <https://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx>

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